

Notice of References Cited		Application/Control No. 10/594,774	Applicant(s)/Patent Under Reexamination SHINDO ET AL.	
		Examiner MARY ANNE KAY	Art Unit 2426	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,302,224	11-2007	Sibley et al.	455/3.02
*	B	US-2003/0154217	08-2003	Kinno et al.	707/104.1
*	C	US-2002/0144007	10-2002	Shteyn, Yevgeniy Eugene	709/313
*	D	US-6,678,332	01-2004	Gardere et al.	375/240.26
*	E	US-6,360,218	03-2002	Zander et al.	1/1
*	F	US-2004/0249861	12-2004	Hoshino et al.	707/104.1
*	G	US-7,134,074	11-2006	Munetsugu et al.	715/204
*	H	US-2002/0166123	11-2002	Schrader et al.	725/58
*	I	US-7,272,843	09-2007	Nejime et al.	725/32
J	US-				
K	US-				
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.